

## DATA SHEET

NEC

## MOS FIELD EFFECT TRANSISTOR

 $\mu$ PA2650T1EDUAL N-CHANNEL MOSFET  
FOR SWITCHING

## DESCRIPTION

The  $\mu$ PA2650T1E is a switching device, which can be driven directly by a 4.5 V power source.

The  $\mu$ PA2650T1E contains dual MOSFET which features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as DC/DC converter of portable machine and so on.

## FEATURES

- 4.5 V drive available MOSFET
- Low on-state resistance MOSFET

MOSFET1  $R_{DS(on)1} = 48 \text{ m}\Omega$  TYP. ( $V_{GS} = 10 \text{ V}$ ,  $I_D = 3.0 \text{ A}$ )

$R_{DS(on)2} = 55 \text{ m}\Omega$  TYP. ( $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 3.0 \text{ A}$ )

MOSFET2  $R_{DS(on)1} = 50 \text{ m}\Omega$  TYP. ( $V_{GS} = 10 \text{ V}$ ,  $I_D = 3.0 \text{ A}$ )

$R_{DS(on)2} = 57 \text{ m}\Omega$  TYP. ( $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 3.0 \text{ A}$ )

## ORDERING INFORMATION

PART NUMBER	PACKAGE
$\mu$ PA2650T1E	6LD3x3MLP

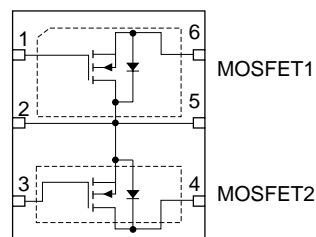
Marking: **A2650**

**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

**Caution** This product is electrostatic-sensitive device due to low ESD capability and should be handled with caution for electrostatic discharge.

$V_{ESD} = \pm 150 \text{ V TYP. (C = 200 pF, R = 0 \Omega, \text{Single Pulse})}$

## PIN CONNECTION (Top View)



- 1: Gate1
- 2: Drain1/Source2 (Heat sink2)
- 3: Gate2
- 4: Drain2 (Heat sink1)
- 5: Drain1/Source2 (Heat sink2)
- 6: Source1

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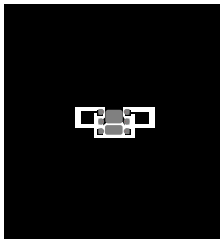
**ABSOLUTE MAXIMUM RATINGS (TA = 25°C)**

**MOSFET1, MOSFET2**

Drain to Source Voltage (V <sub>GS</sub> = 0 V)	V <sub>DSS</sub>	20	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	V <sub>GSS</sub>	±12	V
Drain Current (DC) <sup>Note1</sup>	I <sub>D(DC)</sub>	±3.8	A
Drain Current (pulse) <sup>Note2</sup>	I <sub>D(pulse)</sub>	±15.2	A
Total Power Dissipation <sup>Note1</sup>	P <sub>T</sub>	1.1	W
Channel Temperature	T <sub>ch</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

**Notes 1.** Mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick FR-4 board  
(Cu pad: 322 mm<sup>2</sup> x 70 μm, FR-4: 1452 mm<sup>2</sup> x 1.6 mmt)

**2.** PW ≤ 10 μs, Duty Cycle ≤ 1%



← FET side: 97°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

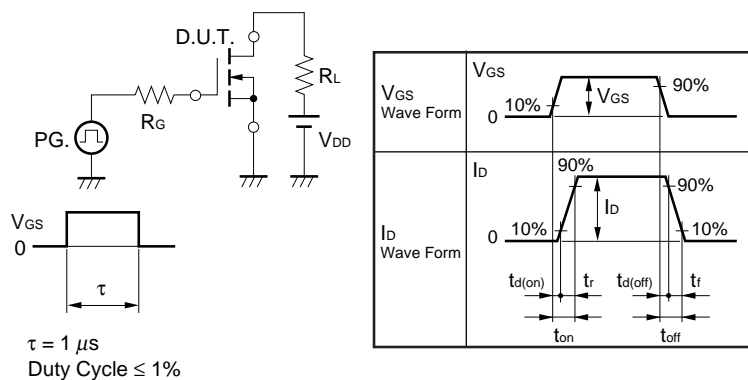
ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)

MOSFET1, MOSFET2

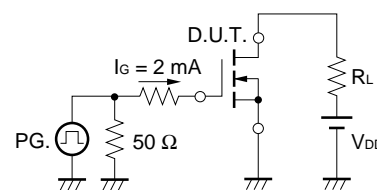
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±12 V, V <sub>DS</sub> = 0 V			±10	μA
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.25 mA	0.6		2.0	V
Forward Transfer Admittance <sup>Note</sup>	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.5 A	1.0	3.6		S
Drain to Source On-state Resistance <sup>Note</sup>	R <sub>DS(on)1</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.0 A	MOSFET1	48	65	mΩ
			MOSFET2	50	65	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.0 A	MOSFET1	55	75	mΩ
			MOSFET2	57	75	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V,		220		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V,		100		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz		40		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.5 A, V <sub>GS</sub> = 4.5 V, R <sub>G</sub> = 10 Ω		8.4		ns
Rise Time	t <sub>r</sub>			7.3		ns
Turn-off Delay Time	t <sub>d(off)</sub>			15		ns
Fall Time	t <sub>f</sub>			3.4		ns
Total Gate Charge	Q <sub>G</sub>		V <sub>DD</sub> = 16 V,		2.9	
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V,		0.6		nC
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 3.0 A		1.0		nC
Body Diode Forward Voltage <sup>Note</sup>	V <sub>F(S-D)</sub>	I <sub>F</sub> = 3.0 A, V <sub>GS</sub> = 0 V		0.89		V

**Note** Pulsed: PW ≤ 350 μs, Duty Cycle ≤ 2%

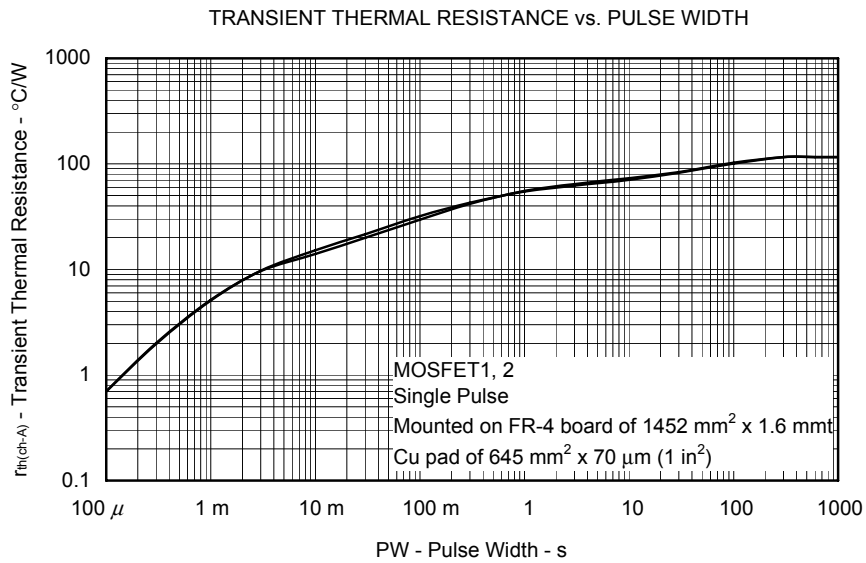
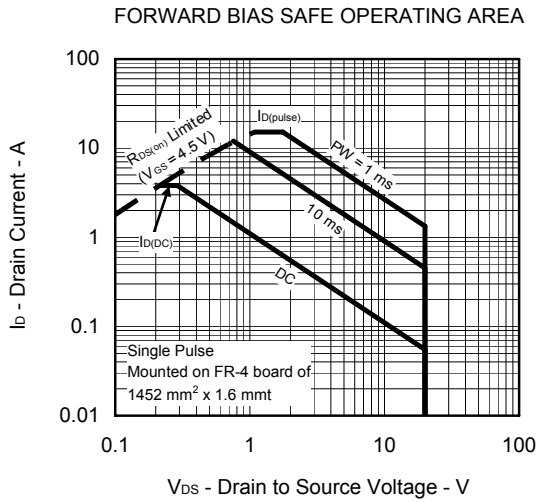
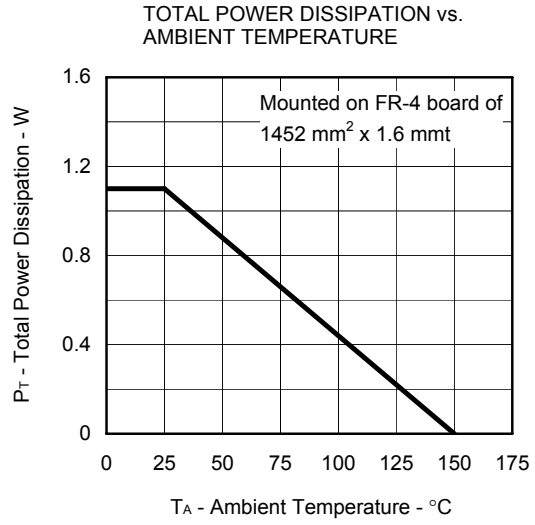
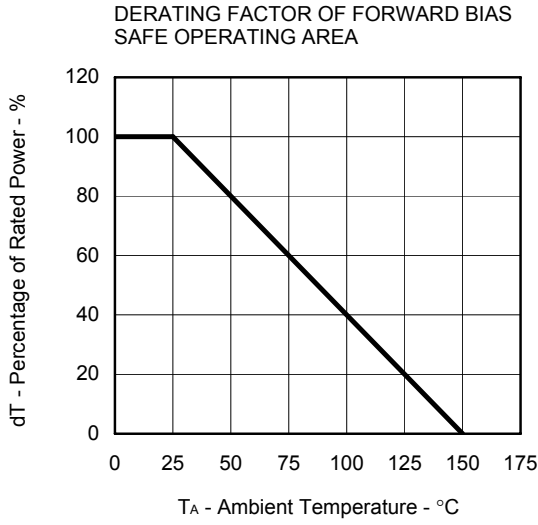
TEST CIRCUIT 1 SWITCHING TIME



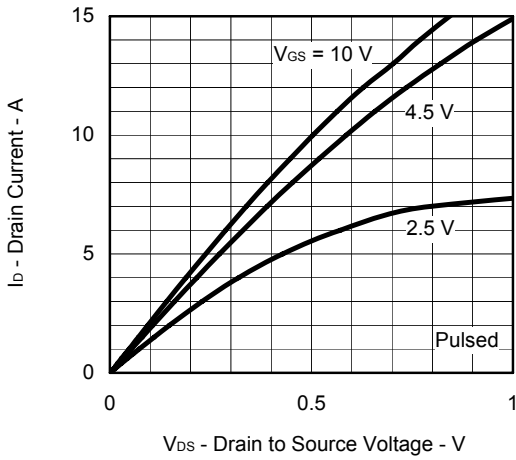
TEST CIRCUIT 2 GATE CHARGE



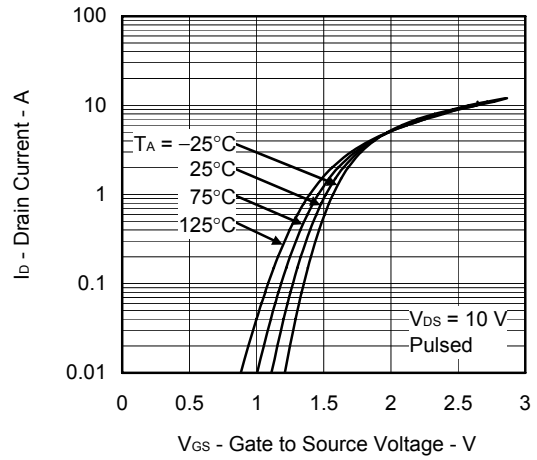
MOSFET TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)



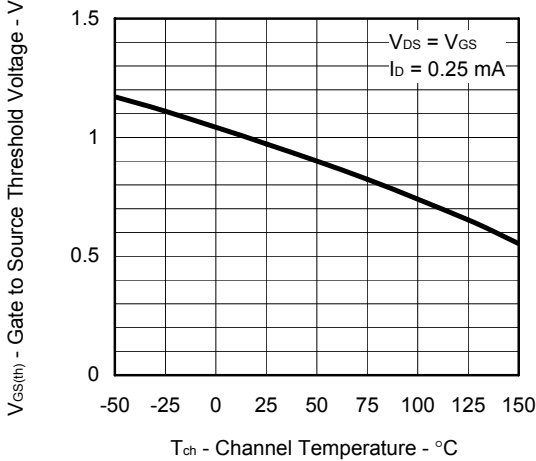
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



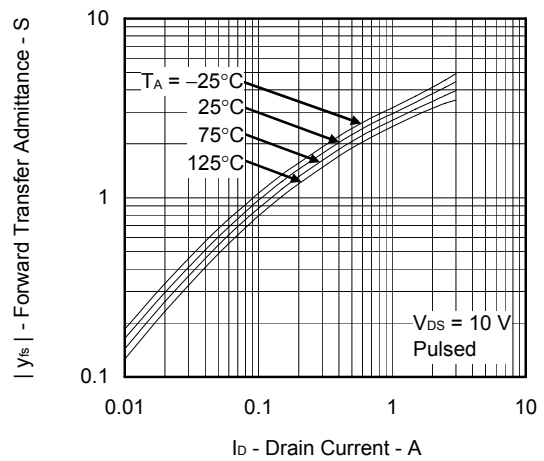
FORWARD TRANSFER CHARACTERISTICS



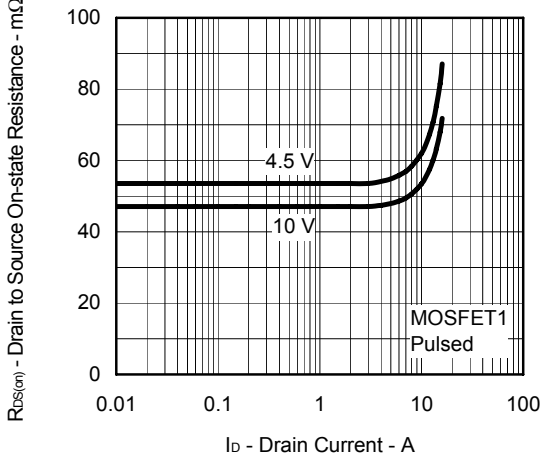
GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



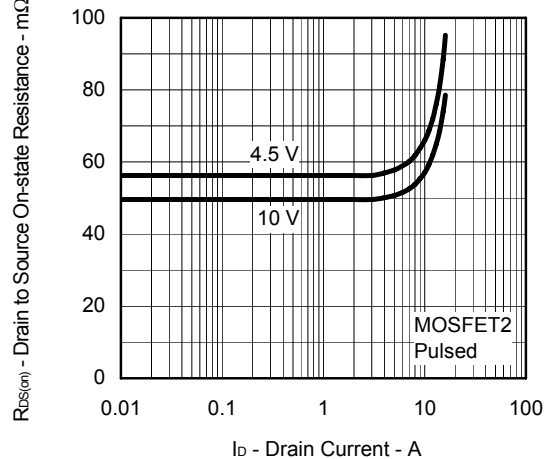
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



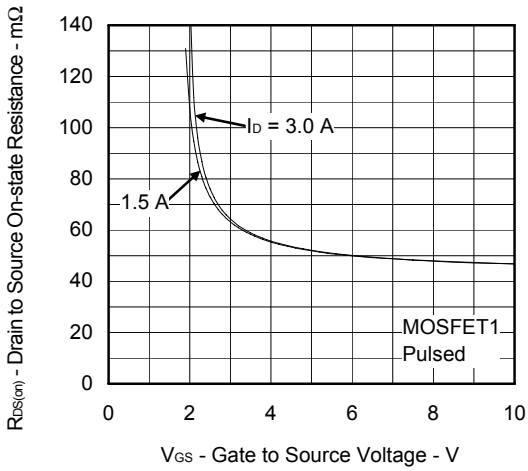
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



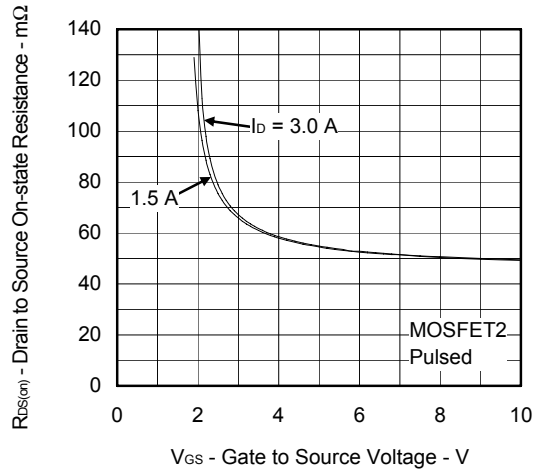
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



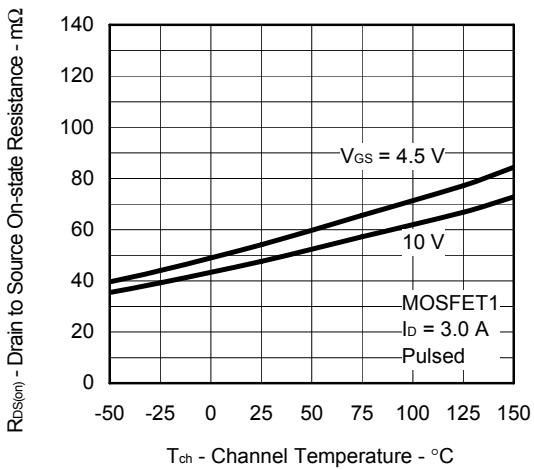
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



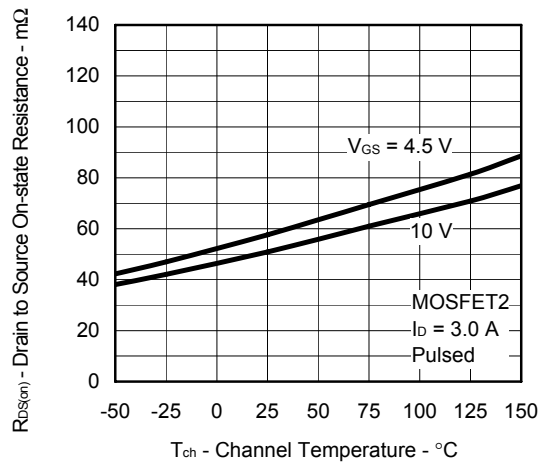
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



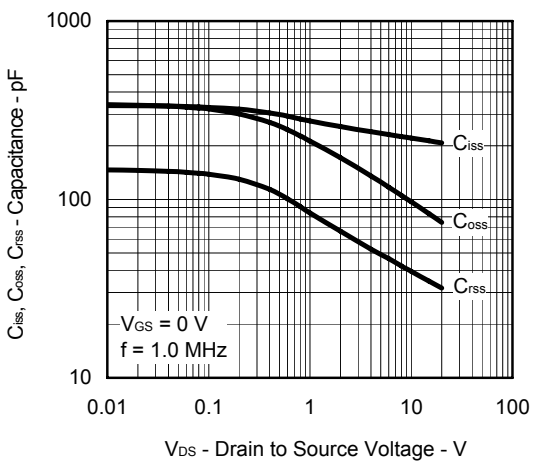
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



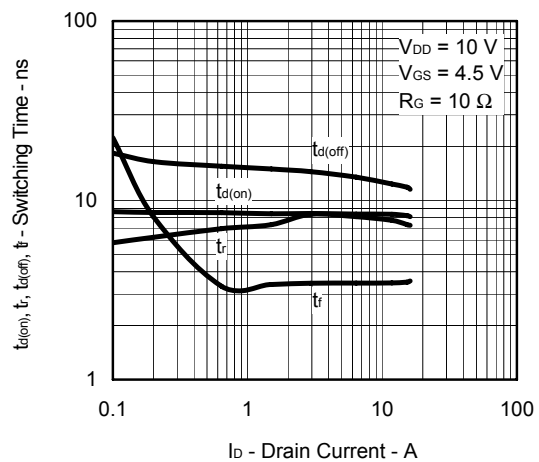
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



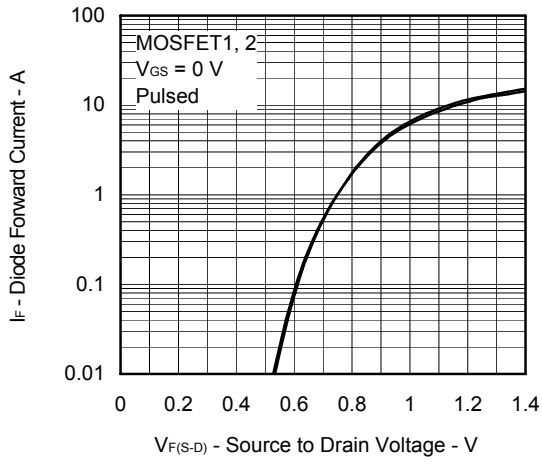
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



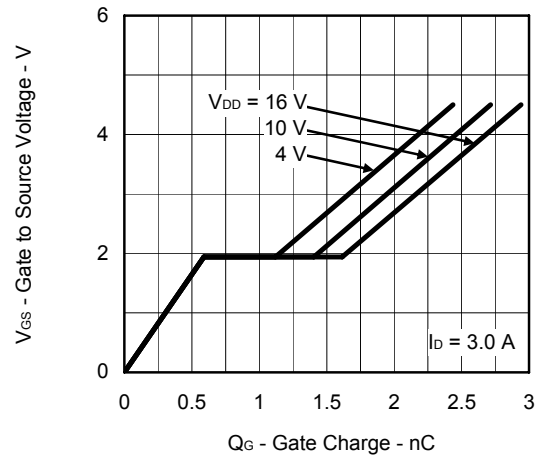
SWITCHING CHARACTERISTICS



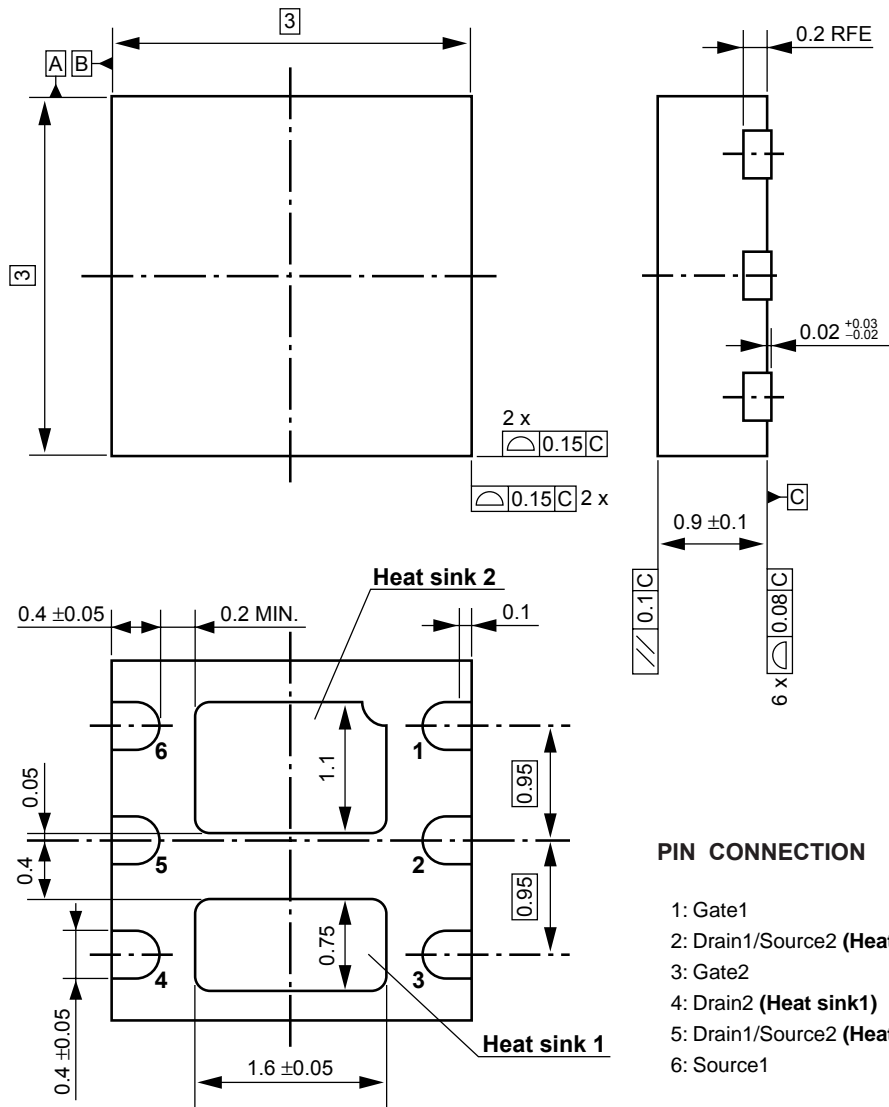
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT CHARACTERISTICS



PACKAGE DRAWING (Unit: mm)



**PIN CONNECTION**

- 1: Gate1
- 2: Drain1/Source2 (Heat sink2)
- 3: Gate2
- 4: Drain2 (Heat sink1)
- 5: Drain1/Source2 (Heat sink2)
- 6: Source1



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